

Remcom's Rotman Lens Designer[®]



General Capabilities

- RLD is a special-purpose software tool for designing Rotman Lenses
- It is based on theoretical equations and Geometrical Optics
- Calculations are performed in real time with interactive redrawing of the design and output quantities
- It is intended for microstrip and stripline lenses at frequencies up to 45 GHz
- It is cross platform compatible for Windows and Linux

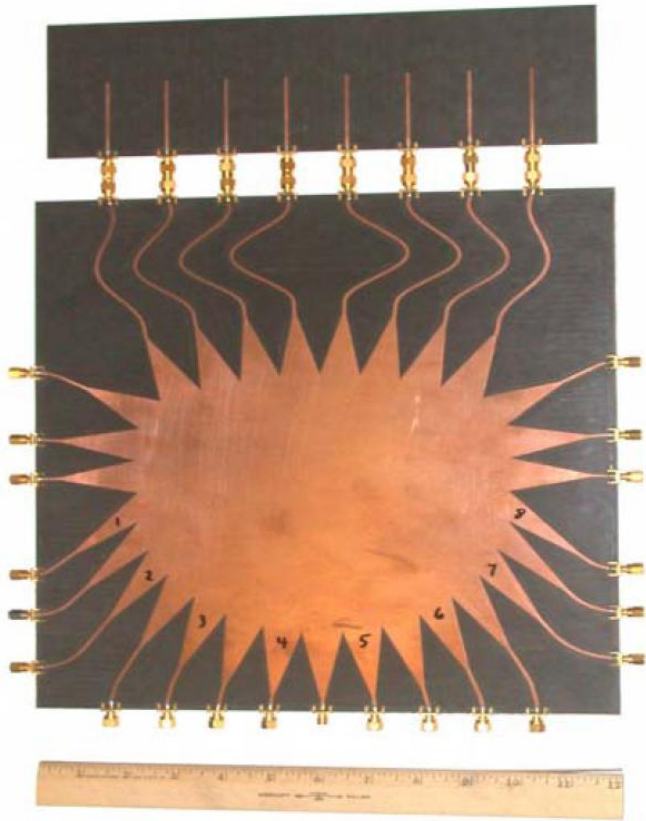


Background

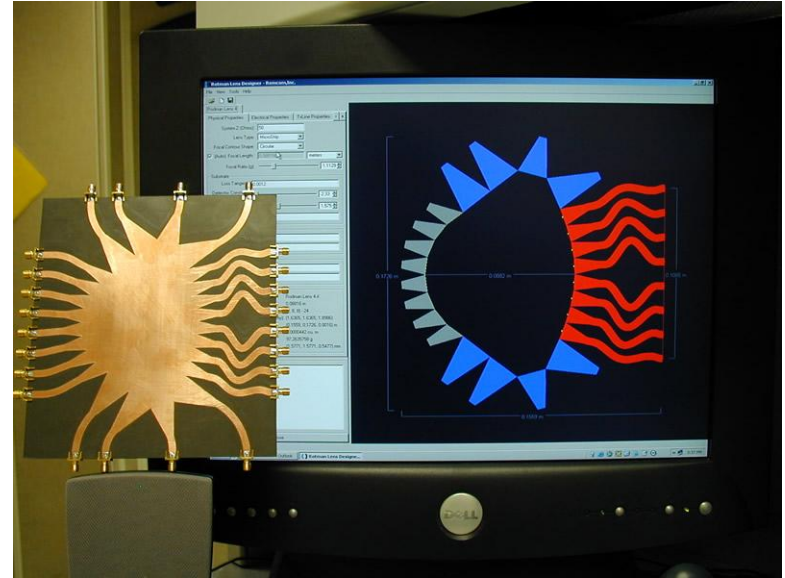
- RLD grew out of a US Army SBIR from the Army Research Laboratory
- Army needed a tool for designing low cost, true time delay beamformers
- Available as a commercial product since 2006
- Successfully used by both the US Army and academic researchers to design and fabricate Rotman Lenses
- Measured results of fabricated lenses have shown good agreement with RLD calculations (see references)



Lenses Built with RLD



4.6 GHz, 8 beam lens
Courtesy Dr. Steven Weiss
US Army Research Laboratory



10 GHz, 8 beam lens shown with RLD design
Courtesy Dr. Erik Lenzing
Penn State Applied Research Laboratory

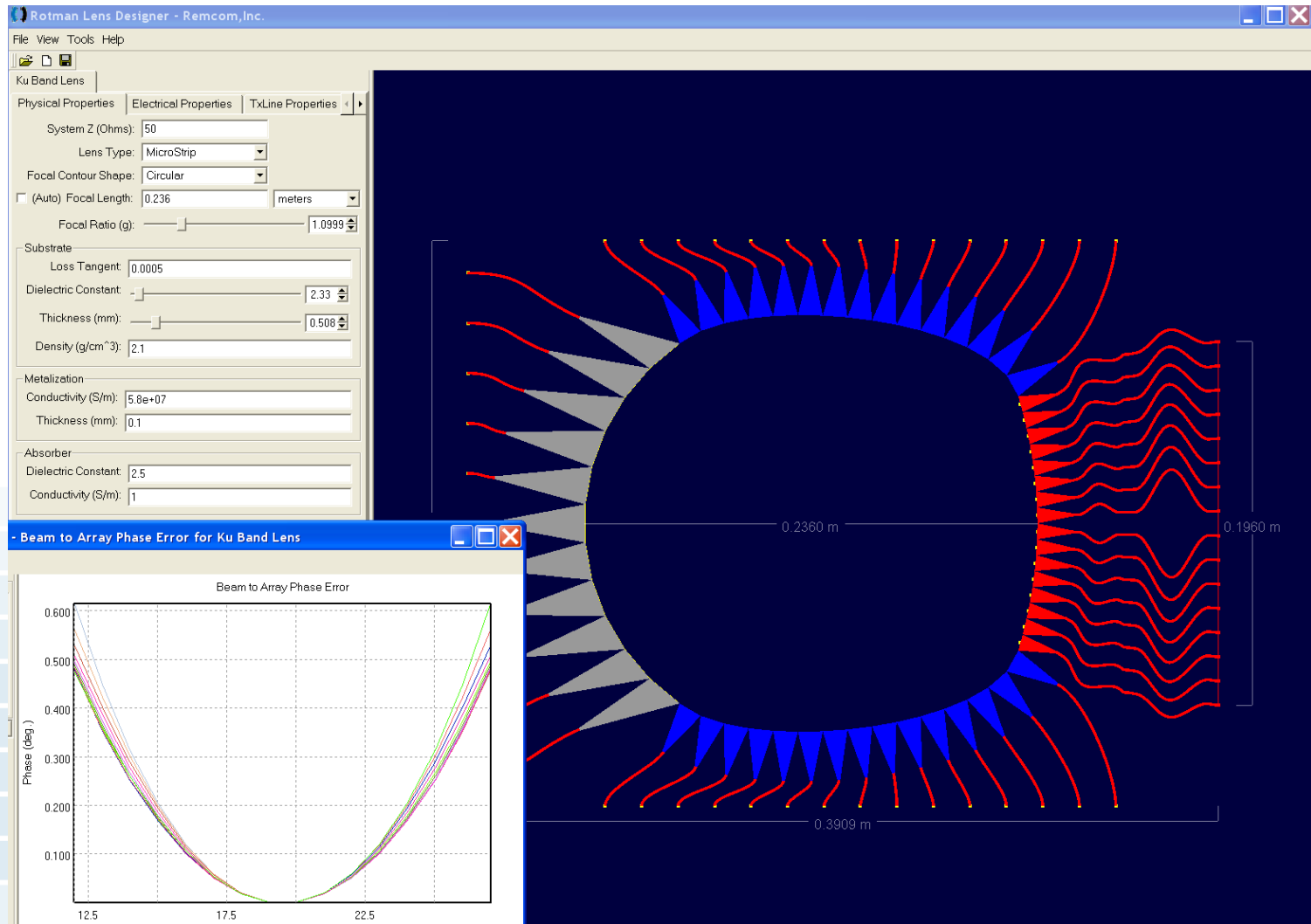


Using RLD

- Typical lens design parameters are available as inputs to the software
- The Lens design is interactively redrawn as parameters are adjusted
- Several performance criteria may be plotted and interactively updated while input parameters are adjusted
- Feed lines to all ports may be added and routed
- Lens design may be exported to a full wave solver for further analysis or into a CAD format for fabrication



The RLD Interface



Input Parameters

- Inputs are divided into categories of physical properties and electrical properties
- Separate tabs list the available parameters
- Most inputs are controlled by both text screens and slider bars
- Lens design is redrawn as the parameters are changed



Physical Properties

- Physical properties are quantities such as the system impedance, the focal length and the focal ratio
- Values for the substrate, metallization layer, and any absorber dielectric are included
- A summary screen lists details about the design

Physical Properties	Electrical Properties	TxLine Properties
System Z (Ohms):	50	
Lens Type:	MicroStrip	
Focal Contour Shape:	Circular	
<input checked="" type="checkbox"/> (Auto) Focal Length:	18.4911	wavelengths
Focal Ratio (g):		1.1370
Substrate		
Loss Tangent:	0.0005	
Dielectric Constant:		2.50
Thickness (mm):		1.524
Density (g/cm ³):	2.1	
Metallization		
Conductivity (S/m):	5.8e+07	
Thickness (mm):	0.1	
Absorber		
Dielectric Constant:	2.5	
Conductivity (S/m):	1	
Lens Info		
Loaded from:	"new lens"	
Focal Length:	18.49110 wavelengths	
Ports (beam, array, dummy) - total:	(16, 32, 0) - 48	
Approx. VSWR (beam, array, dummy):	(1.6365, 1.6365, 1.6365)	
Dimensions (width, height, depth):	(0.4688, 0.5318, 0.0017) m	
Volume:	0.0004299 cu. m	
Weight:	902.7288188 g	
Approx. FDTD cell size (x,y,z):	(1.4535, 1.4535, 0.5747) mm	

Electrical Properties

- Electrical properties include the center frequency, bandwidth, element spacing, and scan angle
- Details about the Beam and Array contours are set
- Control of the sidewall absorption through material or dummies

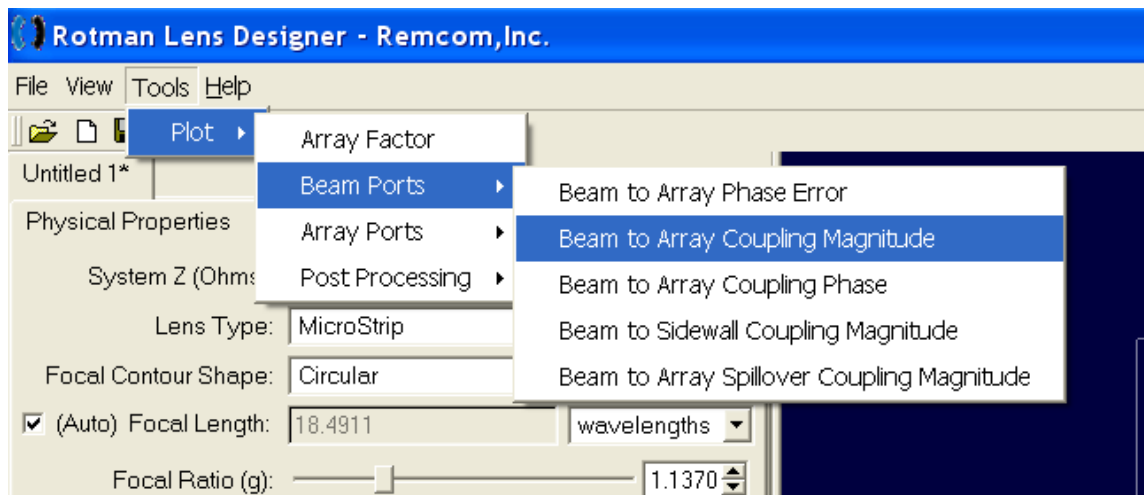
The screenshot shows the 'Electrical Properties' tab of a configuration window. It contains several sections with adjustable parameters:

- Physical Properties:** Center Frequency (MHz): 9600, Bandwidth (MHz): 1600, Element Spacing: 0.46431 (unit: wavelengths), Beam Port Excitation: Uniform, Aperture Distribution: Manual.
- Beam Contour:** Max Scan Angle (degrees): 50.00, Alpha Ratio: 0.800, Number of Beams: 16, Max Port Size (wavelengths): 2.00, Flare Angle (Degrees): 12.00. Includes an unchecked checkbox for 'Enable port pointing'.
- Array Contour:** Number of Elements: 32, Max Port Size (wavelengths): 2.00, Flare Angle (Degrees): 12.00. Includes an unchecked checkbox for 'Enable port pointing'.
- Sidewalls:** Includes a checked checkbox for 'Absorber Sidewalls', Contour Curvature: 0.75, Max Port Size (wavelengths): 2.00, Flare Angle (Degrees): 12.00, and Absorber Width Factor: 0.010.



Design Criteria

- A number of lens performance criteria may be plotted as the design is tuned
- Array factor displays the beam pattern produced at the output elements of the lens
- Beam and Array may be plotted



Output Quantities

- After a lens design is tuned several output values may be computed
- S-parameters and insertion loss are available for every port
- The lens design may be exported in several formats for further analysis or fabrication
- Original intended use of the software was for export of the design to a full wave solver for fine tuning
- Actual use has shown the RLD results are often sufficiently accurate

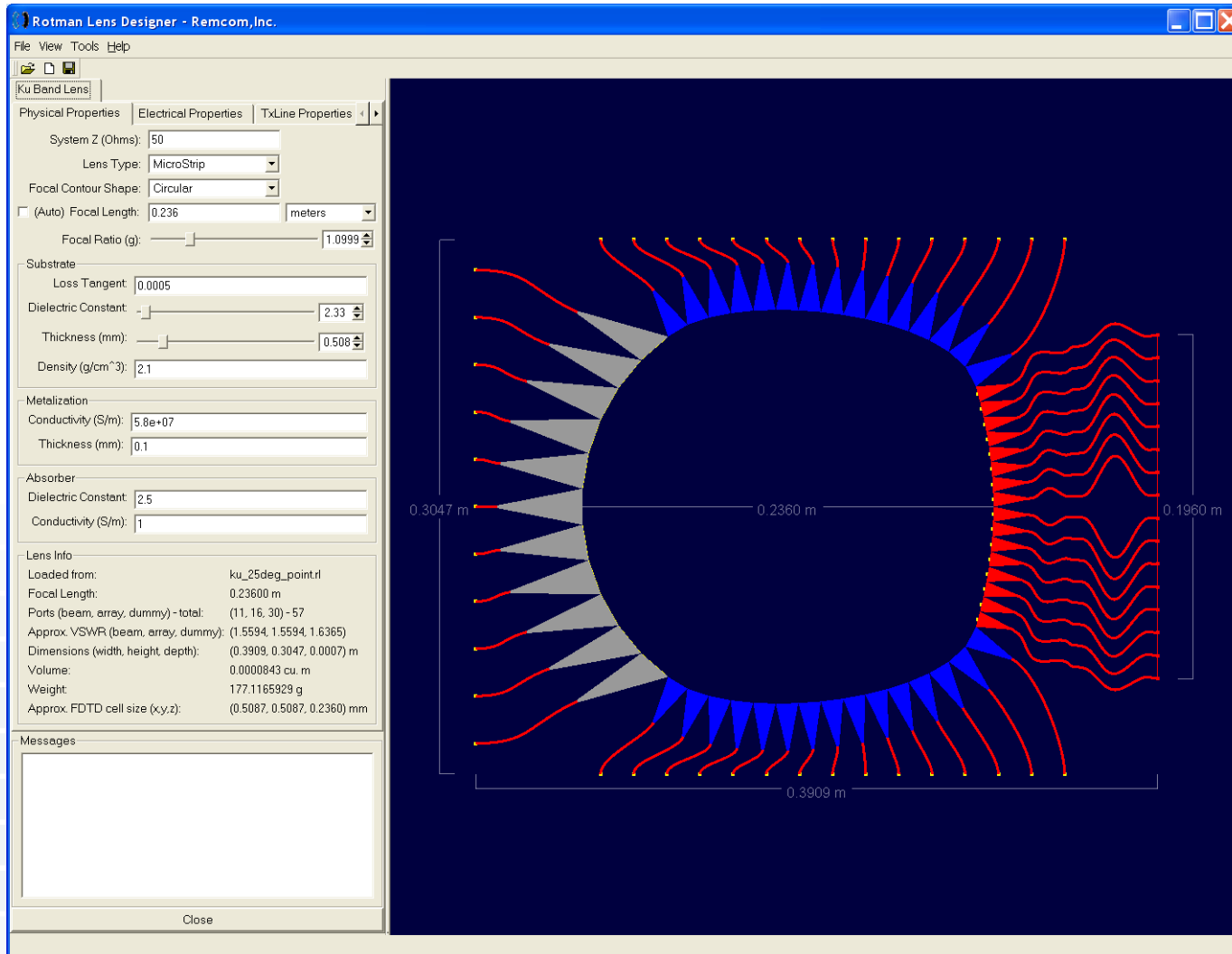


Example Design

- A microstrip lens with a center frequency of 16 GHz will be designed and compared to results from a full wave solver (XFDTD)
- The lens will produce 11 beams for a 16 element linear array with a scan angle of 25 degrees
- Beam patterns and S-parameter results will be compared to XFDTD



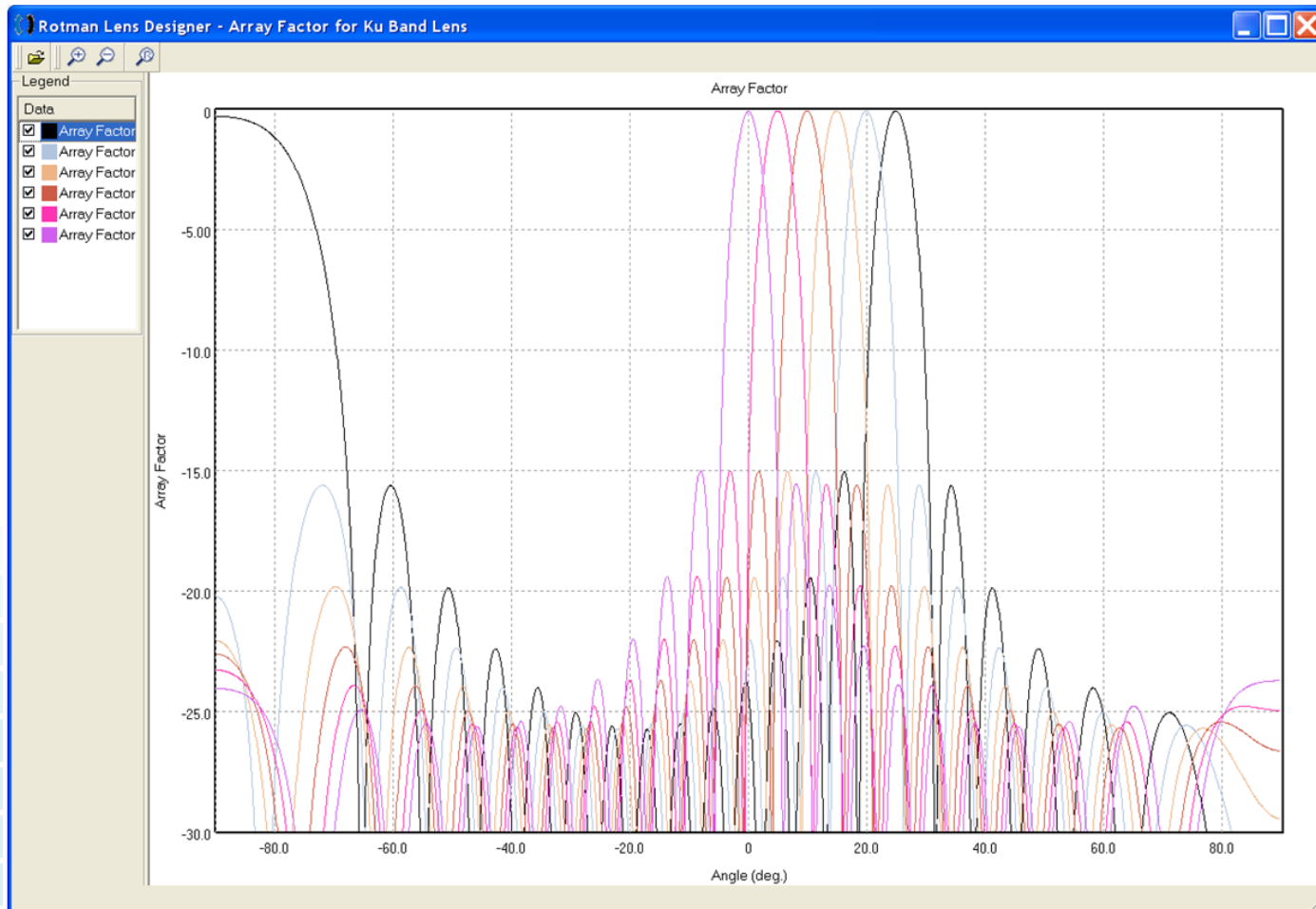
Example Lens Design



Ku band Lens
after tuning



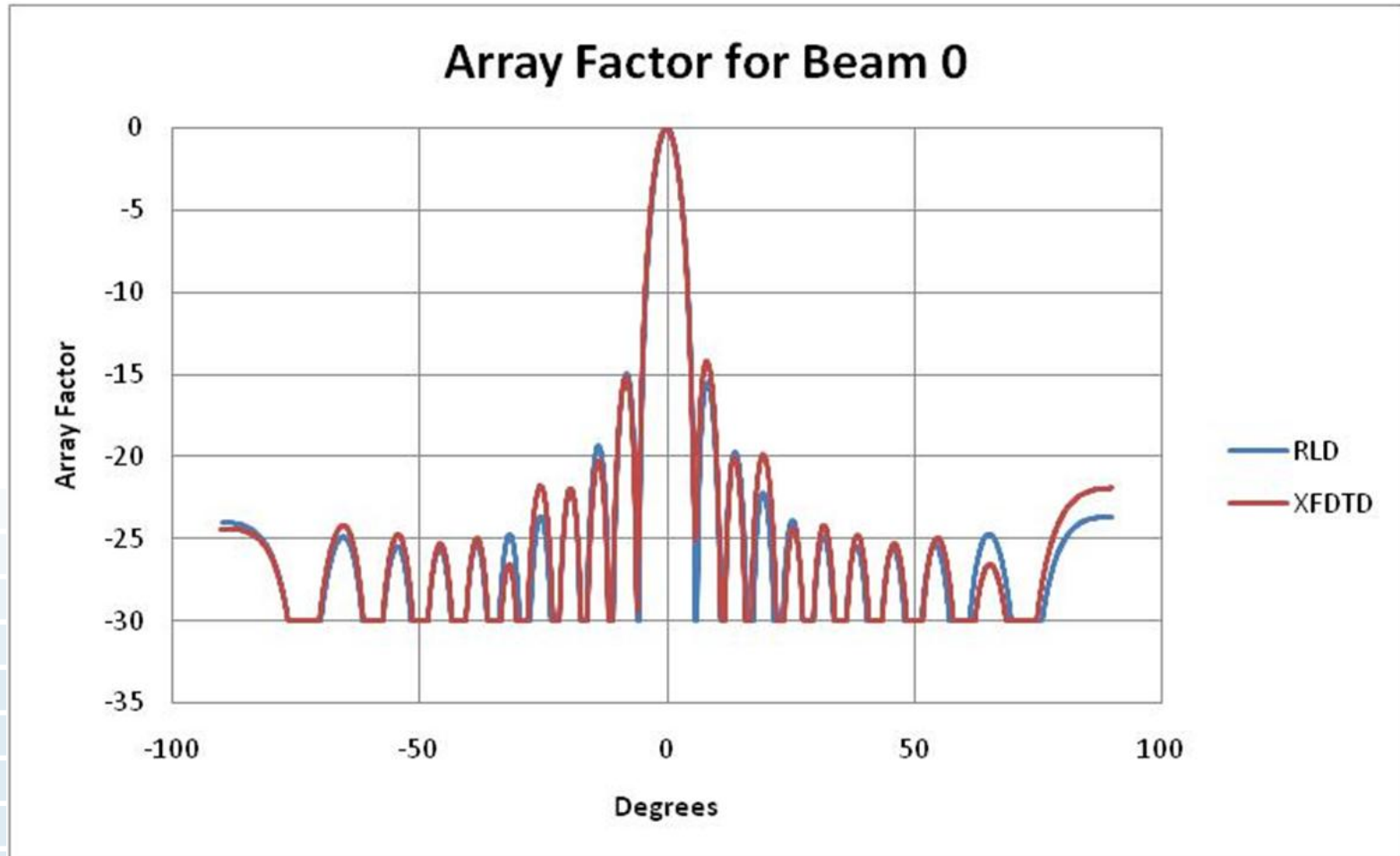
Beam Patterns



Half of the beams formed by the lens are shown



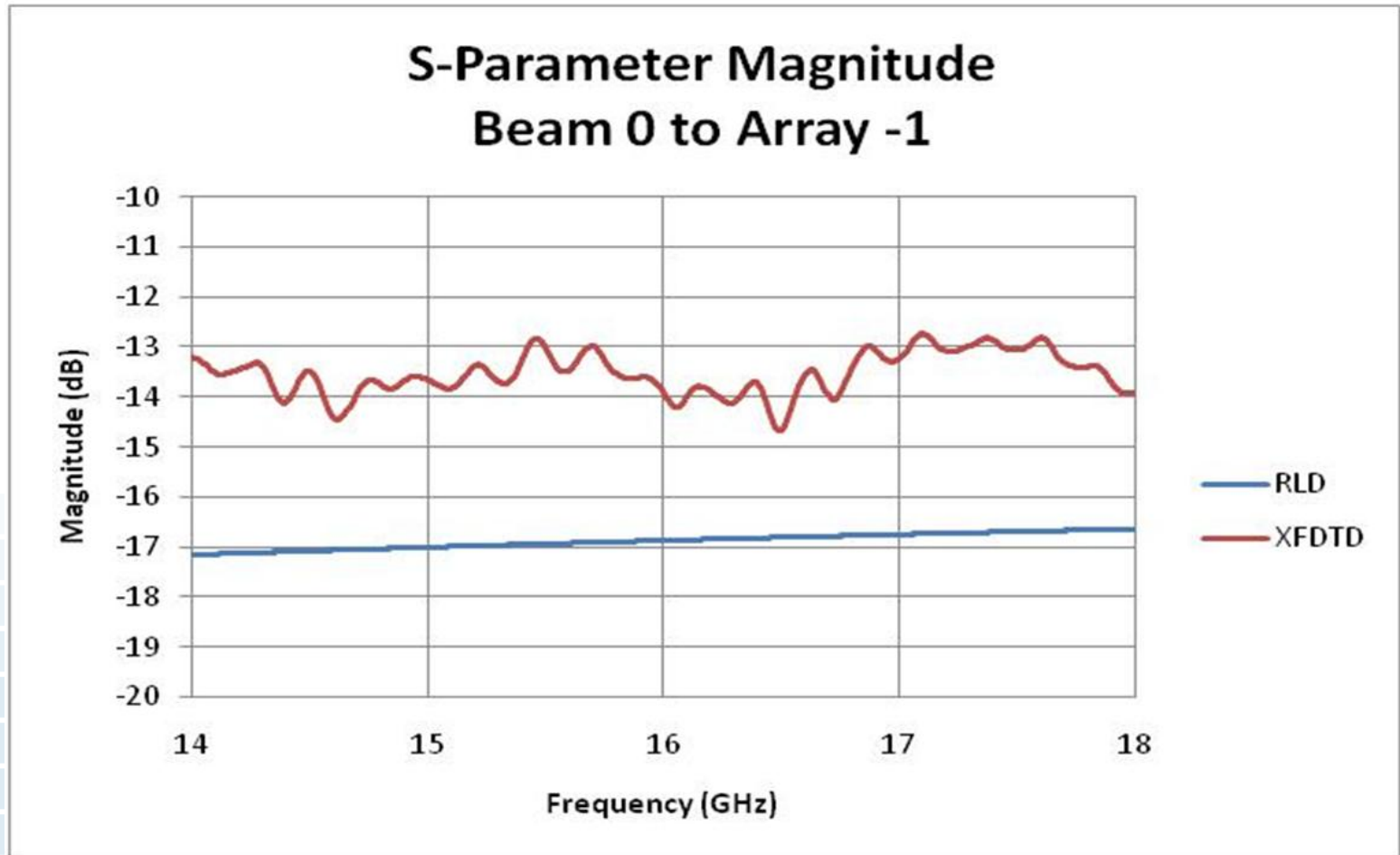
Beam Pattern vs. XFDTD



Good agreement is found for the center beam



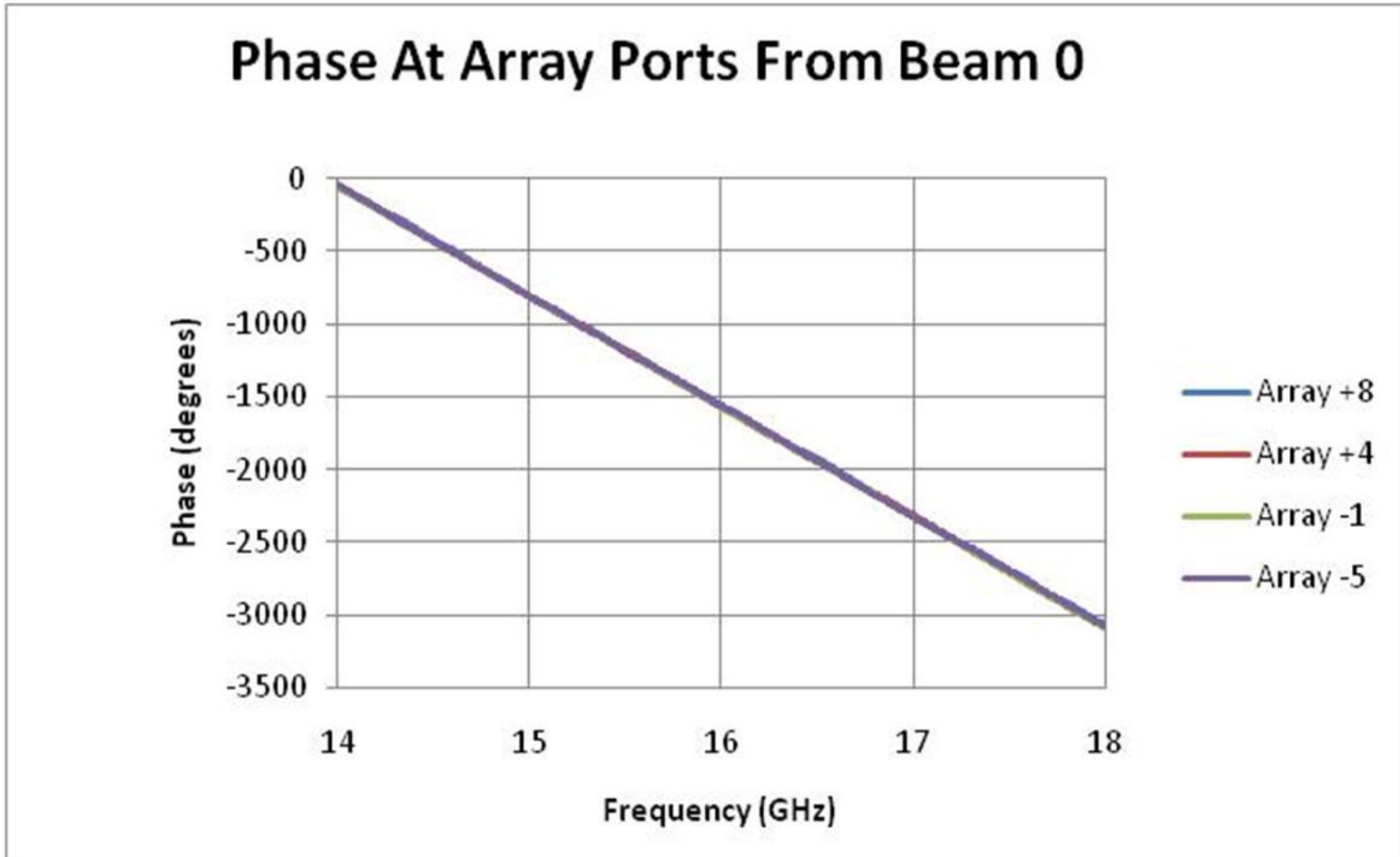
S-Parameter Magnitude vs. Frequency



RLD S-parameter computation is conservative compared to full wave result



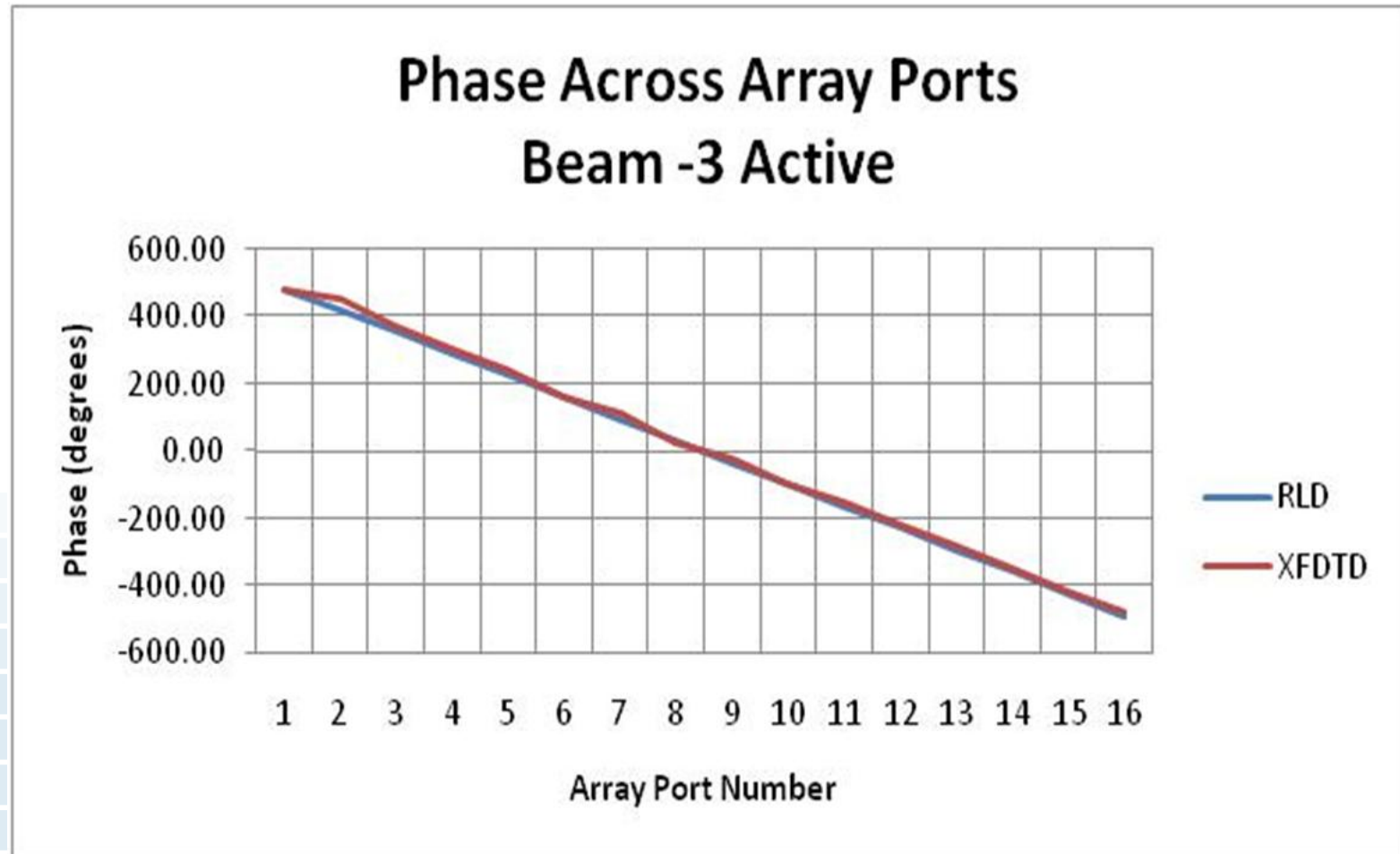
S-Parameter Phase vs. Frequency



Phase remains linear as a function of frequency



S-Parameter Phase across Output Ports



Phase across output (array) ports is in good agreement with XFDTD



Summary

- RLD is an easy to use tool for initial design of Rotman Lenses
- Tuning process is intuitive as output criteria are updated in real time as lens parameters are changed
- Results have been shown to have good agreement with full wave and measured results



References

For further reading on RLD results, including comparisons with measured results, see the following

S. Weiss, S. Keller, and C. Ly, "Development of Simple Affordable Beamformers for Army Platforms," presented at *2007 GOMACTech Conference*, Lake Buena Vista, FL, March 2007.

C. W. Penney, R. J. Luebbers, E. Lenzing, "Broad Band Rotman Lens Simulations in FDTD," in *Proc. 2005 IEEE AP-S International Symposium*, vol. 2B, pp. 51-54, July 2005.

S. Albarano III, E. H. Lenzing, C. W. Penney, and R. J. Luebbers. "Combined Analytical-FDTD Approach to Rotman Lens Design," presented at the *22th Annual Review of Progress in Applied Computational Electromagnetics*, Miami, FL, March 2006.



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